

P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$ (Max.)	I _D (A)	Q _g (Typ.)			
- 30	0.01 7 at V _{GS} = - 4.5 V	-9 ^a	18 nC			
	$0.02 \ 0 \ at \ V_{GS} = -2.5 \ V$	-7 ^a	10110			

FEATURES

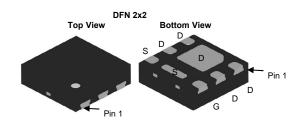
- TrenchFET® Power MOSFET
- Thermally Enhanced DFN2X2 Package
 - Small Footprint Area
 - Low On-Resistance

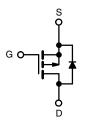


FREE

APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
Parameter	Symbol	Limit	Unit			
Drain-Source Voltage	V_{DS}	- 30	V			
Gate-Source Voltage	V_{GS}	± 12	7			
	T _C = 25 °C		- 9 ^a			
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	l _D	- 8	1		
Continuous Diain Current (1) = 130 O)	T _A = 25 °C		- 8 ^{b, c}	1		
	T _A = 70 °C		- 7 ^{b, c}	Α		
Pulsed Drain Current (t = 300 μs)	I _{DM}	- 25				
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 9 ^a			
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	- 2.5 ^{b, c}			
	T _C = 25 °C		17			
Maximum Power Dissipation	T _C = 70 °C	P _D	11	w		
Maximum Fower Dissipation	T _A = 25 °C	' D	3.3 ^{b, c}	- vv		
	T _A = 70 °C		2.1 ^{b, c}	1		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C			
Soldering Recommendations (Peak Temperatur		250	7 ~			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	28	38	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	5.6	7.5	O/VV		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile The DFN2X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.



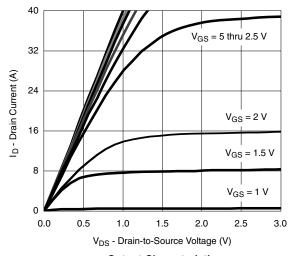
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					L	l	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J I _D = - 250 μA		- 11		m\//0C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.7		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
		V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
		V _{GS} = - 10 V, I _D = - 6.7 A		0.017			
		V _{GS} = - 4.5 V, I _D = - 6.2 A		0.020		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 2.3 A		0.025			
		V _{GS} = - 2.0 V, I _D = - 1 A		0.035		7	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 6.7 A		30		S	
Dynamic ^b						l	
Input Capacitance	C _{iss}			1800		pF	
Output Capacitance	C _{oss}	V _{DS} = - 20 V, V _{GS} = 0 V, f = 1 MHz		430			
Reverse Transfer Capacitance	C _{rss}	20 1 00		370			
T. 10		V _{DS} = - 20 V, V _{GS} = - 8 V, I _D = - 10 A		38	54		
Total Gate Charge	Qg	B6		23	33	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = -20 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$		3			
Gate-Drain Charge	Q_{gd}			6.5			
Gate Resistance	R_{g}	f = 1 MHz		7		Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	$V_{DD} = -20V, R_{L} = 0.75 \Omega$		40	60		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		65	100		
Fall Time	t _f			40	60		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	$V_{DD} = -6 \text{ V}, R_{L} = 0.75 \Omega$		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 8 A, V_{GEN} = - 8 V, R_g = 1 Ω		70	105		
Fall Time	t _f			40	60		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 8	А	
Pulse Diode Forward Current	I _{SM}				-25	^	
Body Diode Voltage	V_{SD}	I _S = -8 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 8 A, di/dt = 100 A/μs, T _J = 25 °C		20	30	nC	
Reverse Recovery Fall Time	t _a	$I_{\rm F} = -8 \text{A}, \text{di/dt} = 100 \text{A/}\mu \text{s}, I_{.1} = 25 \text{G}$		14		ns	
Reverse Recovery Rise Time	t _b			26			

Notes:

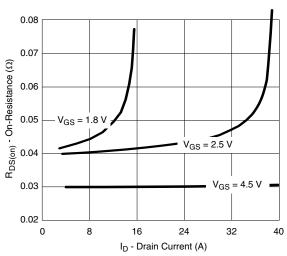
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

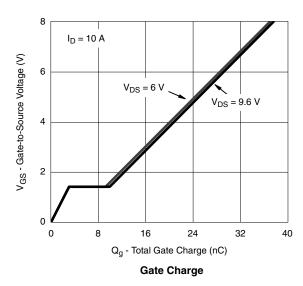






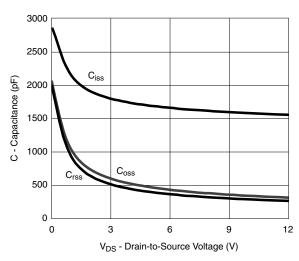


On-Resistance vs. Drain Current and Gate Voltage

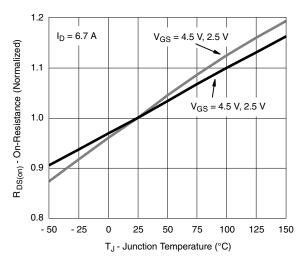


10 8 I_D - Drain Current (A) 6 4 T_C = 25 °C 2 $T_C = 125$ °C $T_C = -55$ °C 0 0.0 0.3 0.6 1.2 0.9 1.5 V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics

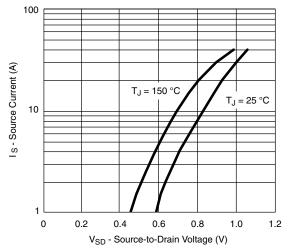


Capacitance

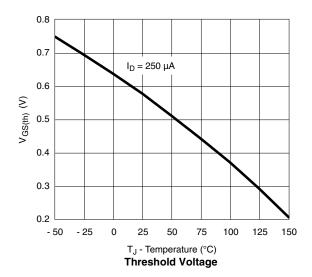


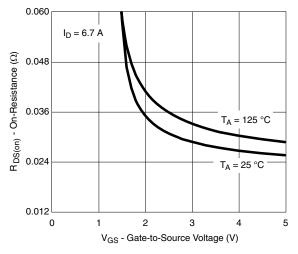
On-Resistance vs. Junction Temperature



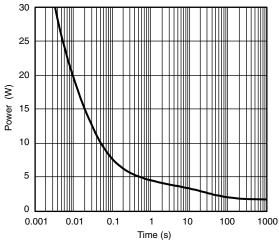


Soure-Drain Diode Forward Voltage

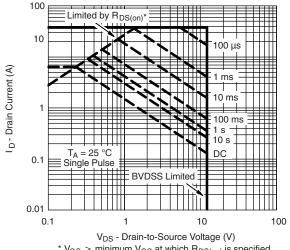




On-Resistance vs. Gate-to-Source Voltage



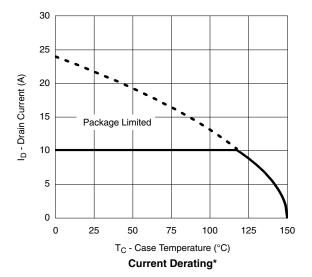
Single Pulse Power, Junction-to-Ambient

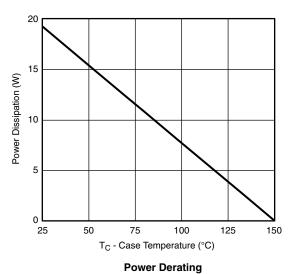


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

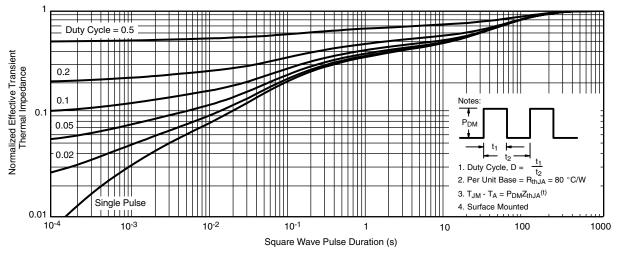




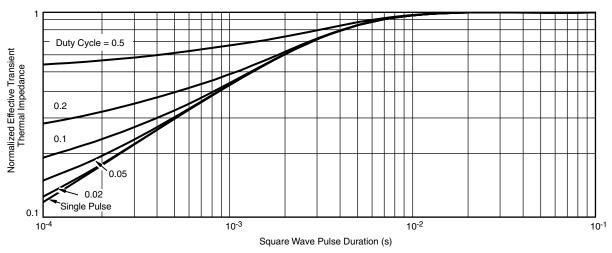


^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





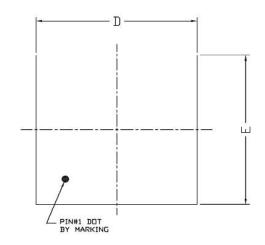
Normalized Thermal Transient Impedance, Junction-to-Ambient

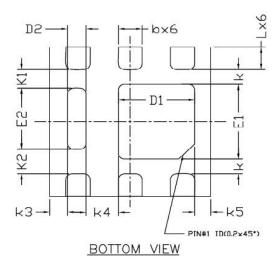


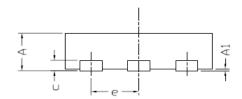
Normalized Thermal Transient Impedance, Junction-to-Case



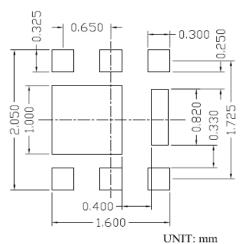
DFN2x2 _6L_EP1_S PACKAGE OUTLINE







RECOMMENDED LAND PATTERN



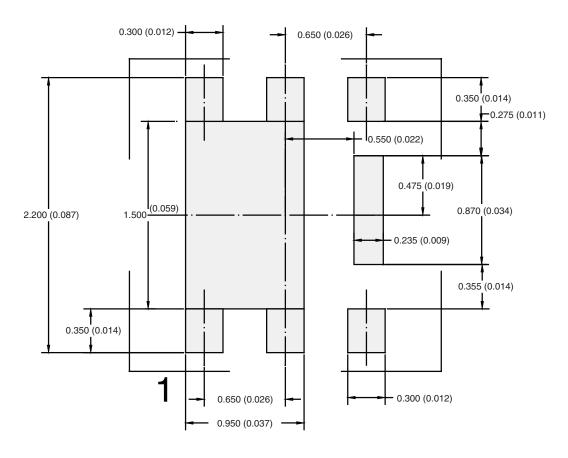
SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
BIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.50	0.55	0.60	0.020	0.022	0.024	
A1	0.00		0.05	0.000		0.002	
ь	0. 25	0.30	0.35	0.010	0.012	0.014	
c	0. 152 REF				0.006 REF		
D	1.90	2.00	2.10	0.075	0.079	0.083	
D1	0.85	0.95	1.05	0.033	0.037	0.041	
D2	0.13	0. 23	0.33	0.005	0.009	0.013	
E	1.90	2.00	2.10	0.075	0.079	0.083	
E1	0.90	1.00	1.10	0.035	0.039	0.043	
E2	0.72	0.82	0.92	0.028	0.032	0.036	
e	0.65 BSC			0. 026 BSC			
K	0. 20 BSC			0.008 BSC			
K1	0. 25 BSC			0.010 BSC			
K2	0. 33 BSC			0. 013 BSC			
K3	0. 22 BSC			0.009 BSC			
K4	0.40 BSC			0. 016 BSC			
K5	0. 20 BSC			0.008 BSC			
L	0.25	0.30	0.35	0.010	0.012	0.014	

NOTE

1. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



RECOMMENDED PAD LAYOUT FOR DFN2X2



Dimensions in mm/(Inches)



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DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
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BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
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